
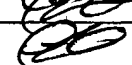


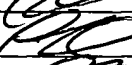

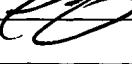

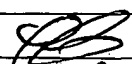

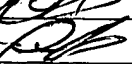


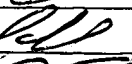

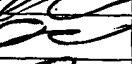




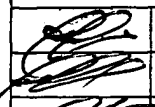


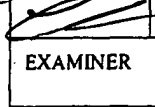



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	APPLICANT Tetsujiro KONDO	
	FILING DATE Filed Concurrently Herewith	GROUP

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5,517,588	05/14/96	Kondo	_____	_____	
	AB	5,068,726	11/26/91	Kondo et al.	_____	_____	
	AC	5,796,858	08/98	Zhou et al.	_____	_____	
	AD	5,559,553	09/96	Bitek	_____	_____	
	AE	5,276,531	01/1994	Chen et al.	_____	_____	
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	AJ	EP 0 430 631 B1	06/05/91	Europe	_____	_____	
	AK	EP 0 571 180 B1	11/24/93	Europe	_____	_____	
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	AN	7-87327	03/31/95	Japan	_____	_____	
	AO	3-167985	07/19/91	Japan	_____	_____	
	AP	1-213088	08/25/89	Japan	_____	_____	
	AQ	5-328185	12/10/93	Japan	_____	_____	
	AR	EP 0 618 727 A1	10/05/94	Europe	_____	_____	
	AS	EP 0 373 924 A1	06/20/90	Europe	_____	_____	
	AT	GB 2 285 361	07/05/95	U.K.	_____	_____	



1.12/05


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	AU	PATENT ABSTRACTS OF JAPAN vol. 1995, no. 06, 31 July 1995 & JP 07 087327 A 31 March 1995
	AV	PATENT ABSTRACTS OF JAPAN vol. 015, no. 200, 22 May 1991 & JP 03 053778 A 7 March 1991
	AW	PATENT ABSTRACTS OF JAPAN vol. 1997, no. 08, 29 August 1997 & JP 09 093285 A 4 April 1997
	AX	PATENT ABSTRACTS OF JAPAN vol. 1997, no. 06, 30 June 1997 & JP 09 055673 A 25 February 1997
EXAMINER 		DATE CONSIDERED 10/12/05
<p>* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>		




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	<b>APPLICANT</b> Tetsujiro KONDO	
	<b>FILING DATE</b> June 24, 2003	<b>GROUP</b> 1621

U.S. PATENT DOCUMENTS							
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	AB						
	AC						
	AD						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	EP 0 419 141	03/27/91	Europe	<del>_____</del>		
	AM						
	AN						
	AO						
	AP						

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	AQ						
	AR						
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<b>EXAMINER</b> 	<b>DATE CONSIDERED</b> 10/12/05
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		APPLICANT Tetsujiro KONDO	
	FILING DATE June 24, 2003	GROUP 1621	

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5 438 635	08/01/95	Richards			
	AB	5 818 974	10/06/98	Kimura et al.			
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	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
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FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
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	AM						
	AN						
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OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
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